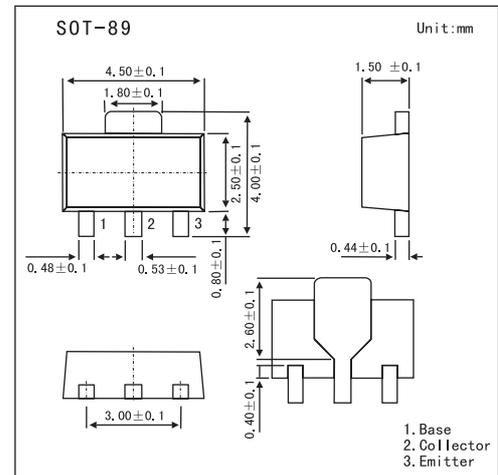


## NPN Epitaxial Planar Silicon Transistor

## 2SD1621

## ■ Features

- Adoption of FBET, MBIT processes.
- Low collector-to-emitter saturation voltage.
- Large current capacity and wide ASO.
- Fast switching speed.
- Very small size making it easy to provide highdensity, small-sized hybrid ICs.

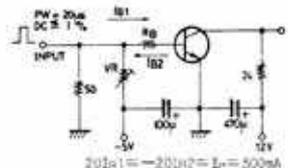
■ Absolute Maximum Ratings  $T_a = 25^\circ\text{C}$ 

| Parameter                 | Symbol    | Rating      | Unit             |
|---------------------------|-----------|-------------|------------------|
| Collector-base voltage    | $V_{CB0}$ | 30          | V                |
| Collector-emitter voltage | $V_{CE0}$ | 25          | V                |
| Emitter-base voltage      | $V_{EB0}$ | 6           | V                |
| Collector current         | $I_C$     | 2           | A                |
| Collector current (pulse) | $I_{CP}$  | 5           | A                |
| Collector dissipation     | $P_C$     | 500         | mW               |
|                           | $P_{C^*}$ | 1.3         | W                |
| Junction temperature      | $T_j$     | 150         | $^\circ\text{C}$ |
| Storage temperature       | $T_{stg}$ | -55 to +150 | $^\circ\text{C}$ |

\* Mounted on ceramic board(250mm2X0.8mm)

## 2SD1621

## ■ Electrical Characteristics Ta = 25°C

| Parameter                            | Symbol               | Testconditions  | Min | Typ  | Max | Unit |    |
|--------------------------------------|----------------------|---|-----|------|-----|------|----|
| Collector cutoff current             | ICBO                 | V <sub>CB</sub> = 20 V, I <sub>E</sub> = 0  |     |      | 0.1 | μA   |    |
| Emitter cutoff current               | IEBO                 | V <sub>EB</sub> = 4 V, I <sub>C</sub> = 0   |     |      | 0.1 | μA   |    |
| DC current gain                      | hFE                  | V <sub>CE</sub> = 2 V, I <sub>C</sub> = 100 mA  | 100 |      | 560 |      |    |
| Gain bandwidth product               | f <sub>T</sub>       | V <sub>CE</sub> = 10 V, I <sub>C</sub> = 50 mA  |     | 150  |     | MHz  |    |
| Output capacitance                   | C <sub>ob</sub>      | V <sub>CB</sub> = 10 V, f = 1.0MHz  |     | 19   |     | pF   |    |
| Collector-emitter saturation voltage | V <sub>CE(sat)</sub> | I <sub>C</sub> = 1.5 A, I <sub>B</sub> = 75 mA  |     | 0.18 | 0.4 | V    |    |
| Base-emitter saturation voltage      | V <sub>BE(sat)</sub> | I <sub>C</sub> = 1.5 A, I <sub>B</sub> = 75 mA  |     | 0.85 | 1.2 | V    |    |
| Collector-base breakdown voltage     | V <sub>(BR)CBO</sub> | I <sub>C</sub> = 10μA, I <sub>E</sub> = 0   | 30  |      |     | V    |    |
| Collector-emitter breakdown voltage  | V <sub>(BR)CEO</sub> | I <sub>C</sub> = 1mA, R <sub>BE</sub> = ∞   | 25  |      |     | V    |    |
| Emitter-base breakdown voltage       | V <sub>(BR)EBO</sub> | I <sub>E</sub> = 10μA, I <sub>C</sub> = 0   | 6   |      |     | V    |    |
| Turn-on time                         | t <sub>on</sub>      | <b>Switching Time Test Circuit</b><br> |     | 60   |     | ns   |    |
| Storage time                         | t <sub>stg</sub>     |   |     |      | 500 |      | ns |
| Turn-off time                        | t <sub>f</sub>       |   |     |      | 25  |      | ns |

## ■ hFE Classification

| Marking | DD      |         |         |         |
|---------|---------|---------|---------|---------|
| Rank    | R       | S       | T       | U       |
| hFE     | 100~200 | 140~280 | 200~400 | 280~560 |